MD9407: Noise spectrum and emittance growth with different ADT gain

X. Buffat, A. Fornara, S. Kostoglou, G. Sterbini , D. Valuch

Steps to be taken during MD

- Test the ADT setup at injection **(Just added to the procedure)**
  - Inject one batch of 8b from the SPS in each beam ($2 \cdot 10^{11}$ p/b, 2 μm)
  - Deploy ADT mask with different gain for the different bunch.
  - Kick individual bunches to calibrate the gain
  - Restore ADT settings
  - Dump
- Perform the measurement at flat top
  - Inject 80 bunches per beam, 8 bunches per injection ($2 \cdot 10^{11}$ p/b, 2 μm)
  - Ramp, squeeze and collide with beta* levelling in nominal conditions. (The luminosity from the experiment is needed for lumi-scans)
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  - Monitor emittance (BSRT), luminosity evolution (experiments) and bunch-by-bunch transverse positions (ADTObsbox)
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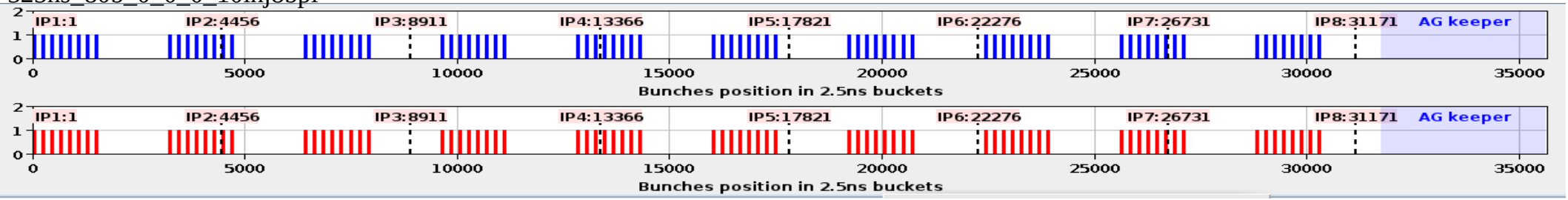
  - Repeat the measurement with a different set of ADT gains in collision

525ns_80b_0_0_0_10inj8bpi



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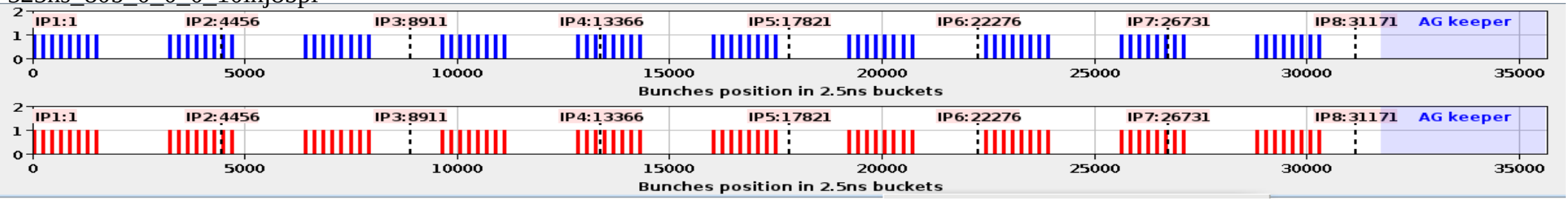

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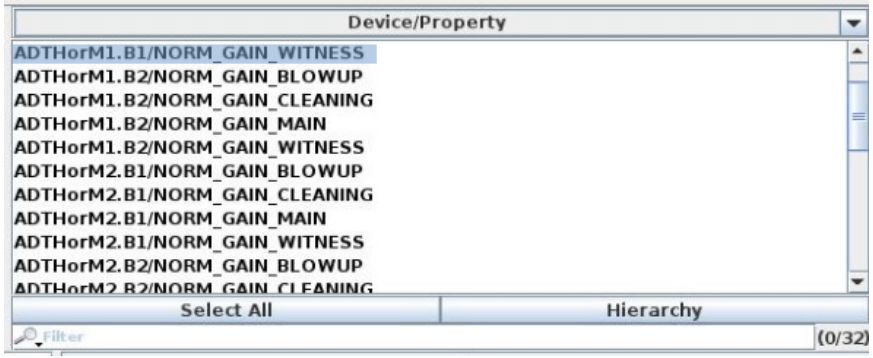

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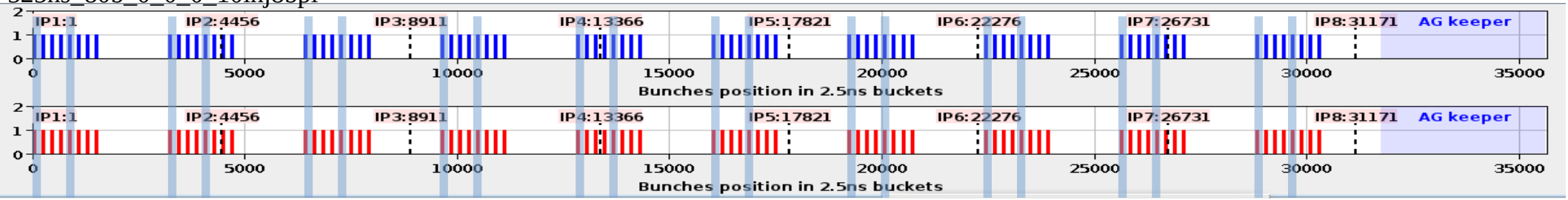

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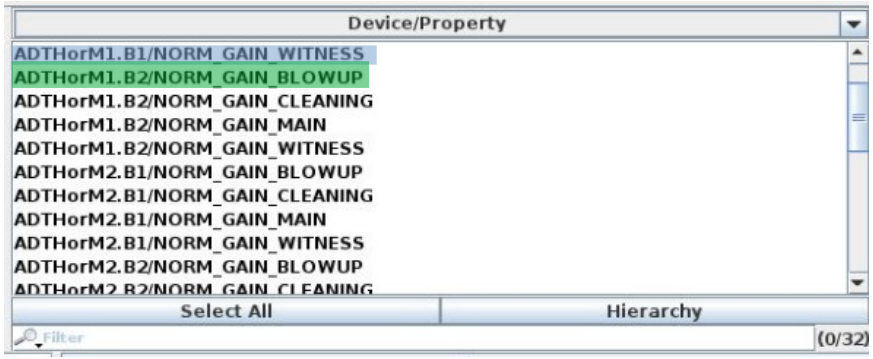

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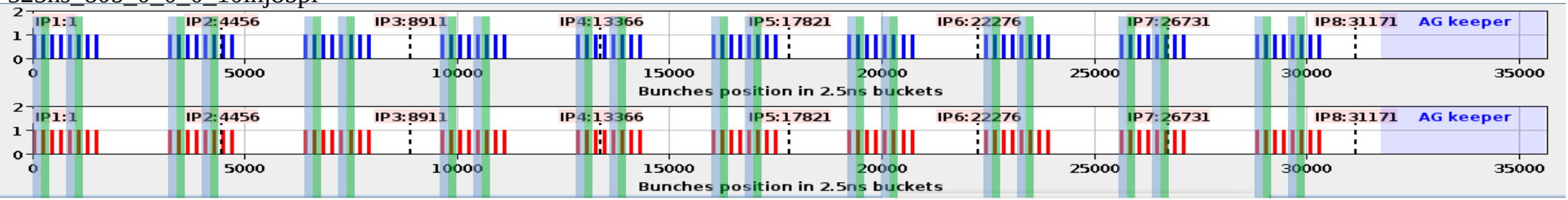

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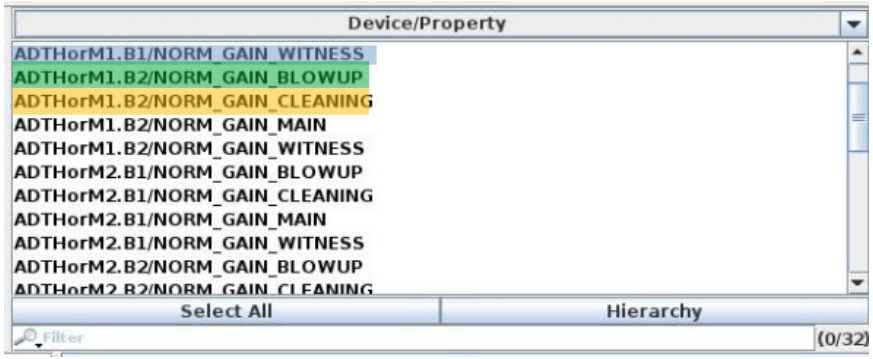

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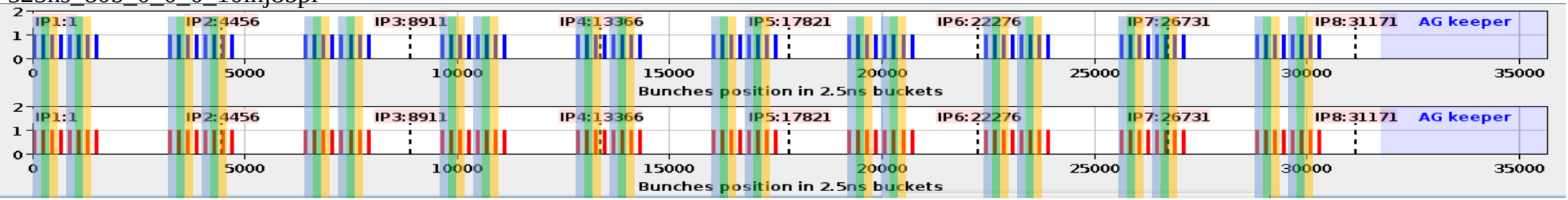

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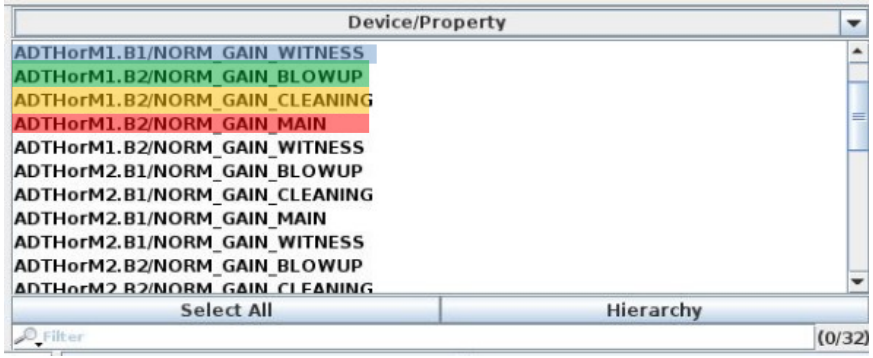

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